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December 9, 2004

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 Art Unit: 2881
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 Date: December 9, 2004
 Subjct: Response to Office Action
 Docket No.: F070
 Pages: 16 (*including this coversheet*)

APPLICATION NO.: 09/840,558

ART UNIT: 2881

APPLICANT: Robert L. Gerlach

EXAMINER: Paul M. Gurzo

FILING DATE: April 23, 2001

TITLE: Collection of Secondary Electrons Through the Objective Lens of a Scanning Electron Microscope

Attached please find:

1. Response to Office Action (13 pages)
2. Petition for 1 Month Extension of Time with Deposit Account Authorization (in duplicate)

Michael O. Scheinberg
Patent Reg. No.: 36.919

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Attorney Docket F070

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICATION NO.: 09/840,558**ART UNIT: 2881****RECEIVED
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DEC 09 2004****APPLICANT: Robert L. Gerlach****EXAMINER: Paul M. Gurzo****FILING DATE: April 23, 2001****TITLE:** Collection of Secondary Electrons through the Objective Lens of a Scanning Electron Microscope**RESPONSE TO OFFICE ACTION**

Commissioner for Patents
P.O. Box 14503
Alexandria, VA 22313-1450

In response to the Office Action of August 9, 2004, please amend the above-identified application as follow:

Amendments to the Claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks/Arguments begin on page 10 of this paper.

CERTIFICATE OF TRANSMISSION UNDER 37 C.F.R. 1.8

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on Dec 9, 2004

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